



RoHS Compliant



MDES14N045RH

Single N-channel Trench MOSFET 135V, 180A, 4.5mΩ

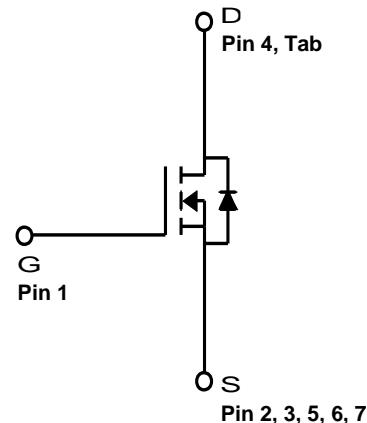
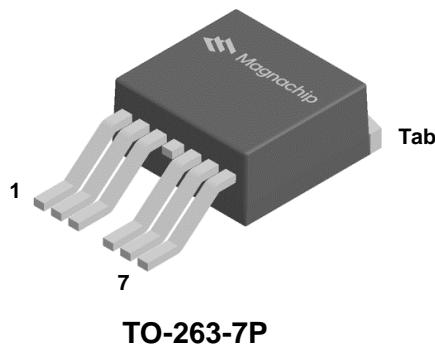
General Description

The MDES14N045RH, Magnachip's latest generation of MV MOSFET Technology, which provides high performance in the lowest R_{ds(on)}, fast switching performance, and excellent quality.

These devices can also be utilized in industrial applications such as Low Power Drives of E-bike, Light electric vehicles, DC/DC converter, and general purpose applications.

Features

- V_{DS} = 135V
- I_D = 180A @V_{GS} = 10V
- Very low on-resistance R_{DS(ON)}
- < 4.5 mΩ @V_{GS} = 10V
- 175 °C operating temperature
- 100% UIL Tested
- 100% R_g Tested
- 100% △V_{DS} Tested



Absolute Maximum Ratings (T_J = 25 °C)

Characteristics		Symbol	Rating	Unit
Drain-Source Voltage		V _{DSS}	135	V
Gate-Source Voltage		V _{GSS}	±20	V
Continuous Drain Current ⁽¹⁾	T _C =25°C (Silicon Limited)	I _D	204	A
	T _C =25°C (Package Limited)		180	
	T _C =100°C (Silicon Limited)		144	
Pulsed Drain Current ⁽²⁾		I _{DM}	720	
Power Dissipation	T _C =25°C	P _D	375	W
	T _C =100°C		187	
Single Pulse Avalanche Energy ⁽³⁾		E _{AS}	450	mJ
Junction and Storage Temperature Range		T _J , T _{stg}	-55~175	°C

Thermal Characteristics

Characteristics		Symbol	Rating	Unit
Thermal Resistance, Junction-to-Ambient		R _{θJA}	40	°C/W
Thermal Resistance, Junction-to-Case		R _{θJC}	0.4	

MDES14N045RH-Single N-Channel Trench MOSFET 135V

Ordering Information

Part Number	Temp. Range	Package	Packing	RoHS Status
MDES14N045RH	-55~175°C	TO-263-7P	Tape & Reel	Halogen Free

Electrical Characteristics ($T_J = 25^\circ\text{C}$)

Characteristics	Symbol	Test Condition	Min	Typ	Max	Unit
Static Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$I_D = 250\mu\text{A}, V_{\text{GS}} = 0\text{V}$	135	-	-	V
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}} = V_{\text{GS}}, I_D = 250\mu\text{A}$	2.5	-	3.9	
Drain Cut-Off Current	I_{DSS}	$V_{\text{DS}} = 135\text{V}, V_{\text{GS}} = 0\text{V}$	-	-	1.0	μA
Gate Leakage Current	I_{GSS}	$V_{\text{GS}} = \pm 20\text{V}, V_{\text{DS}} = 0\text{V}$	-	-	± 0.1	
Drain-Source ON Resistance	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}} = 10\text{V}, I_D = 50\text{A}$	-	3.8	4.5	$\text{m}\Omega$
Forward Transconductance	g_{fs}	$V_{\text{DS}} = 10\text{V}, I_D = 50\text{A}$	-	122	-	S
Dynamic Characteristics						
Total Gate Charge	Q_g	$V_{\text{DS}} = 70\text{V}, I_D = 50\text{A}, V_{\text{GS}} = 10\text{V}$	-	123	-	nC
Gate-Source Charge	Q_{gs}		-	41	-	
Gate-Drain Charge	Q_{gd}		-	22	-	
Input Capacitance	C_{iss}	$V_{\text{DS}} = 70\text{V}, V_{\text{GS}} = 0\text{V}, f = 1.0\text{MHz}$	-	9,267	-	pF
Reverse Transfer Capacitance	C_{rss}		-	27	-	
Output Capacitance	C_{oss}		-	923	-	
Turn-On Delay Time	$t_{\text{d(on)}}$	$V_{\text{GS}} = 10\text{V}, V_{\text{DS}} = 70\text{V}, I_D = 50\text{A}, R_G = 3.0\Omega$	-	36	-	ns
Rise Time	t_r		-	21	-	
Turn-Off Delay Time	$t_{\text{d(off)}}$		-	83	-	
Fall Time	t_f		-	13	-	
Gate Resistance	R_g	$f=1\text{ MHz}$	-	3	-	Ω
Drain-Source Body Diode Characteristics						
Source-Drain Diode Forward Voltage	V_{SD}	$I_S = 50\text{A}, V_{\text{GS}} = 0\text{V}$	-	0.9	1.2	V
Body Diode Reverse Recovery Time	t_{rr}	$I_F = 50\text{A}, dI/dt = 125\text{A}/\mu\text{s}$	-	117	-	ns
Body Diode Reverse Recovery Charge	Q_{rr}		-	538	-	nC

Note :

1. Surface mounted FR-4 board by JEDEC (jesd51-7). Continuous current at $T_c=25^\circ\text{C}$ is silicon limited
2. Pulse width limited by $T_{J,\text{max}}$
3. E_{AS} is tested at starting $T_J = 25^\circ\text{C}$, $L = 1.0\text{mH}$, $I_{AS} = 30\text{A}$, $V_{\text{GS}} = 10\text{V}$.

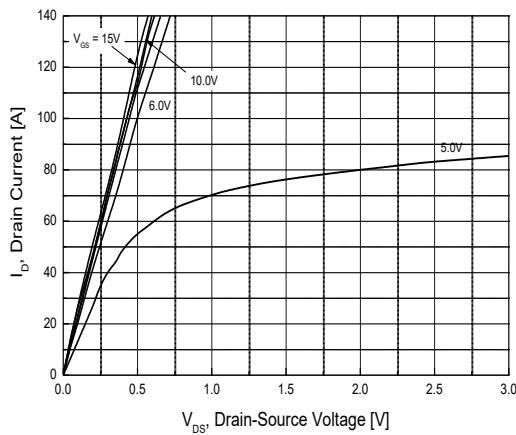


Fig.1 On-Region Characteristics

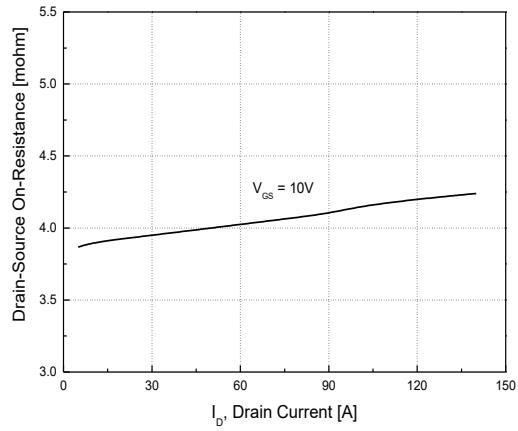


Fig.2 On-Resistance Variation with Drain Current and Gate Voltage

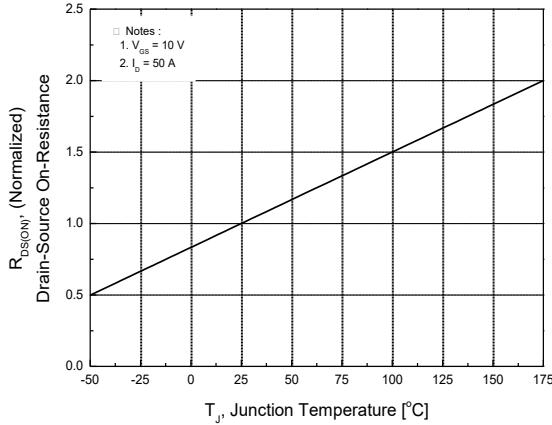


Fig.3 On-Resistance Variation with Temperature

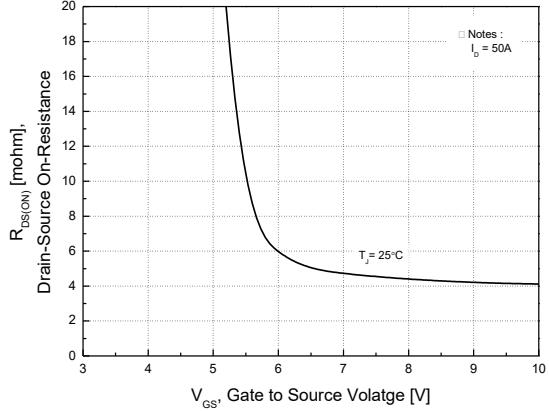


Fig.4 On-Resistance Variation with Gate to Source Voltage

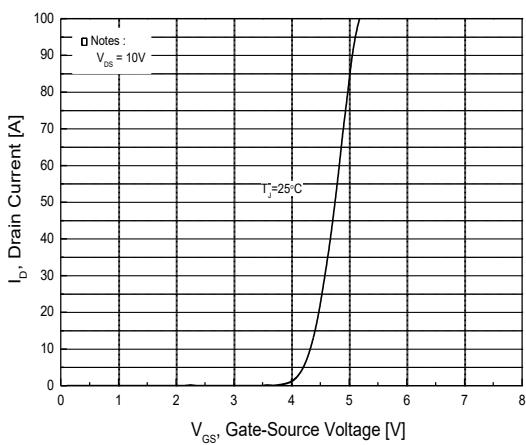


Fig.5 Transfer Characteristics

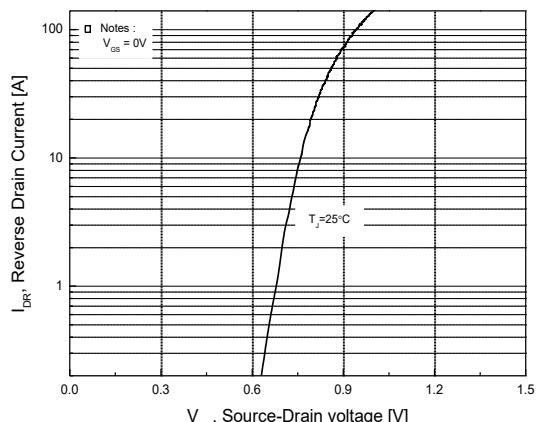


Fig.6 Body Diode Forward Voltage Variation with Source Current and Temperature

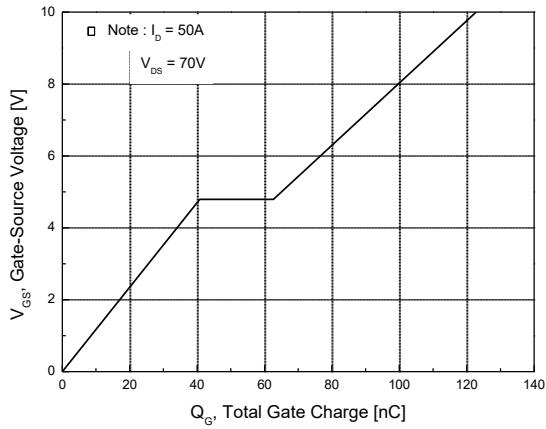


Fig.7 Gate Charge Characteristics

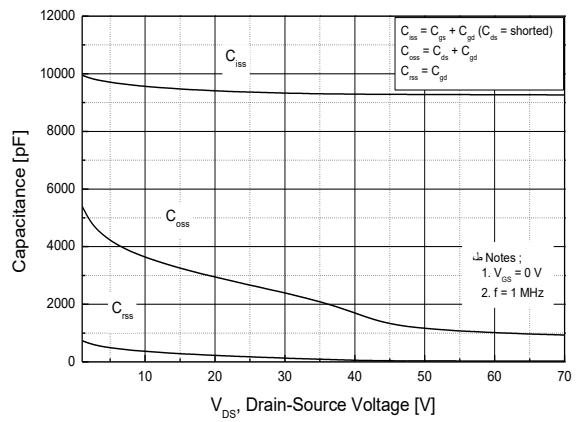


Fig.8 Capacitance Characteristics

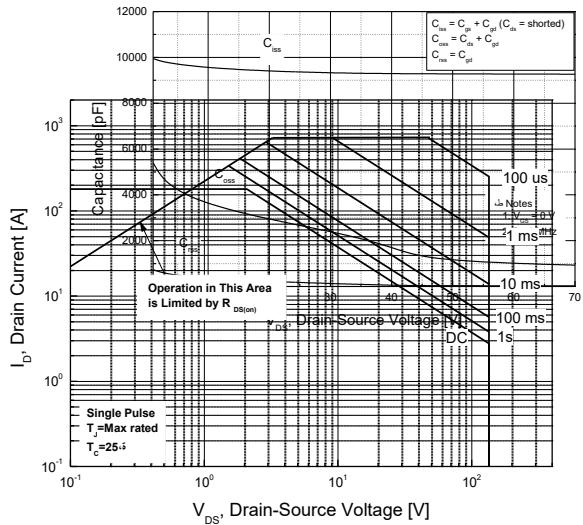


Fig.9 Maximum Safe Operating Area

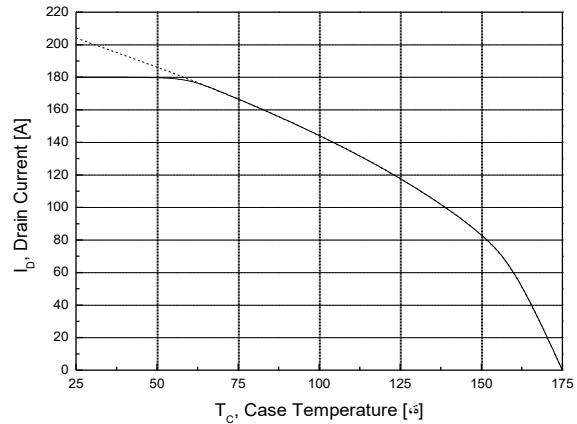


Fig.10 Maximum Drain Current vs. Case Temperature

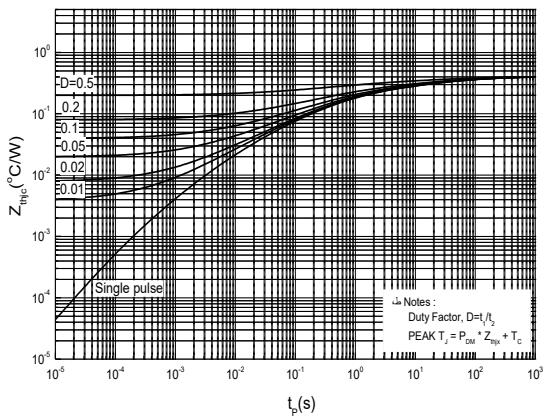
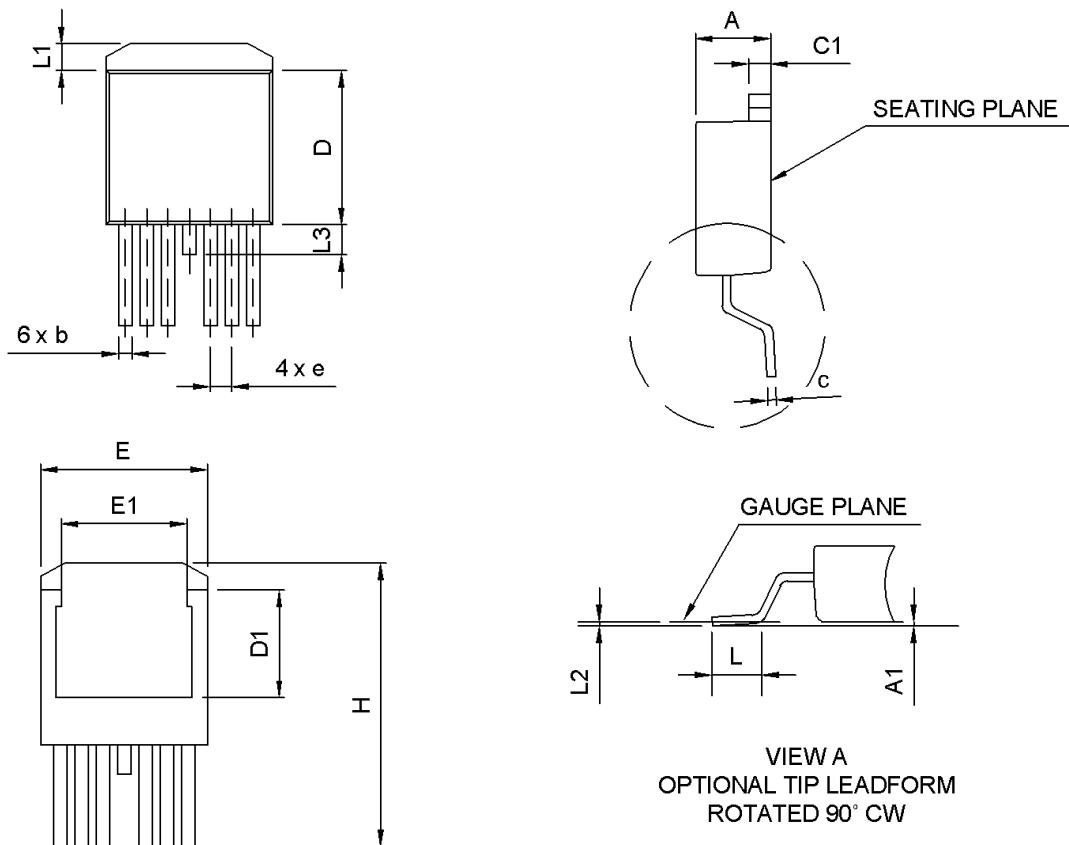


Fig.11 Transient Thermal Response Curve

Package Dimension

TO-263-7P

Dimensions are in millimeters unless otherwise specified



VIEW A
OPTIONAL TIP LEADFORM
ROTATED 90° CW

Symbol	Dimension [mm]	
	Min	Max
A	4.30	4.70
A1	-	0.254
b	0.65	0.90
c	0.40	0.60
c1	1.25	1.40
D	9.00	9.40
D1	5.90	6.90
E	9.68	10.20
E1	7.70	8.50
e	1.27BSC	
H	14.61	15.88
L	1.78	2.80
L1	-	1.6
L2	0.254BSC	
L3	-	1.78

Note : Package body size, length and width do not include mold flash, protrusions and gate burrs.

DISCLAIMER:

The Products are not designed for use in hostile environments, including, without limitation, aircraft, nuclear power generation, medical appliances, and devices or systems in which malfunction of any Product can reasonably be expected to result in a personal injury. Seller's customers using or selling Seller's products for use in such applications do so at their own risk and agree to fully defend and indemnify Seller.

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